

L Number	Hits	Search Text	DB	Time stamp
712	54	wafer\$1 and (center\$3 same defect\$3 same flat)	USPAT	2003/11/19 15:43
713	82	wafer\$1 and (center\$3 same damag\$3 same flat)	USPAT	2003/11/19 13:47
714	81	(wafer\$1 and (center\$3 same damag\$3 same flat)) not (wafer\$1 and (center\$3 same defect\$3 same flat))	USPAT	2003/11/19 13:47
725	4	("4011748"   "4741212"   "5479252"   "5592295").PN.	USPAT	2003/11/19 15:04
726	5	6062084.URPN.	USPAT	2003/11/19 15:07
773	5	("4685206"   "4887904"   "4938654"   "5125791"   "5308222").PN.	USPAT	2003/11/19 15:30
774	12	5851102.URPN.	USPAT	2003/11/19 15:31
795	14	("3988068"   "4213042"   "5072128"   "5114230"   "5504345"   "5592295"   "5706081"   "5798831"   "5898492"   "5903342"   "5936726"   "6038019"   "6062084"   "6656580"   "6172745").PN.	USPAT	2003/11/19 15:40
796	7228	wafer\$1 and (defect\$3 or damag\$2) same (position\$1 or align\$4)	USPAT	2003/11/19 15:44
797	100	wafer\$1 same (crack\$2) same (position\$1)	USPAT	2003/11/19 15:59
798	90	wafer\$1 same (crack\$2) same (align\$4)	USPAT	2003/11/19 15:59
799	71	(wafer\$1 same (crack\$2) same (align\$4)) not (wafer\$1 same (crack\$2) same (position\$1))	USPAT	2003/11/19 15:56
800	772	wafer\$1 same (defect\$1) same (position\$1)	USPAT	2003/11/19 15:59
801	768	(wafer\$1 same (defect\$1) same (position\$1)) not (wafer\$1 same (crack\$2) same (align\$4)) not (wafer\$1 same (crack\$2) same (position\$1))	USPAT	2003/11/19 15:59
-	12	an-hyeon\$.in.	USPAT; US-PGPUB	2003/11/18 08:32
-	1	an-hyeon-su\$.in.	EPO; JPO; DERWENT	2003/11/18 08:32
-	238	(250/559.3).CCLS.	USPAT	2003/11/18 09:22
-	1050	(250/559.42-559.48).CCLS.	USPAT	2003/11/18 09:22
-	1031	((250/559.42-559.48).CCLS.) not ((250/559.3).CCLS.)	USPAT	2003/11/18 10:47
-	631	(414/935-936).CCLS.	USPAT	2003/11/19 08:41